


<b>Search Notes</b>  	<b>Application/Control No.</b>  10791441	<b>Applicant(s)/Patent Under Reexamination</b>  HYUN ET AL.
	<b>Examiner</b>  Ho, Huy C	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
370	445	2/1/2007	HH
370	466	2/1/2007	HH
710	18	2/1/2007	HH
370	508		

SEARCH NOTES		
Search Notes	Date	Examiner
EAST image and keyword search in USPATConclusion, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB (See attached search strategy)	2/1/2007	HH
Search update	8/25/2007	HH
Search update	9/24/2008	HH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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